UNISONIC TECHNOLOGIES CO., LTD

10N65-Q **Power MOSFET**

10A, 650V N-CHANNEL **POWER MOSFET**

DESCRIPTION

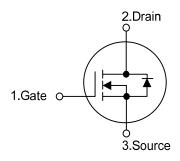
The UTC 10N65-Q is an N-channel Power MOSFET using UTC's advanced technology to provide customers a minimum on-state resistance and superior switching performance, etc.

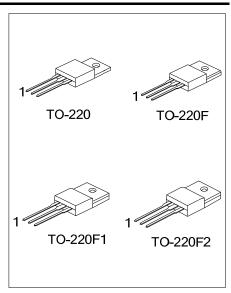
The UTC 10N65-Q is generally applied in high efficient DC to DC converters, PWM motor controls and bridge circuits, etc.

FEATURES

- * $R_{DS(ON)}$ < 1.0 Ω @ V_{GS} =10V, I_D = 5 A
- * High Switching Speed
- * Improved dv/dt capability

SYMBOL

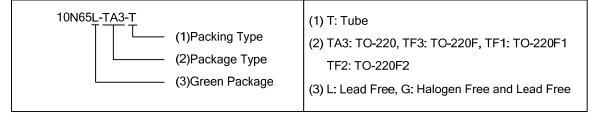




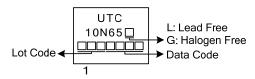
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
10N65L-TA3-T	10N65G-TA3-T	TO-220	G	D	S	Tube	
10N65L-TF3-T	10N65G-TF3-T	TO-220F	G	D	S	Tube	
10N65L-TF1-T	10N65G-TF1-T	TO-220F1	G	D	S	Tube	
10N65L-TF2-T	10N65G-TF2-T	TO-220F2	G	D	S	Tube	

S: Source Note: Pin Assignment: G: Gate D: Drain



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	±30	V
Avalanche Current (Note 2)		I _{AR}	10	Α
Drain Current	Continuous	I _D	10	Α
	Pulsed (Note 2)	I_{DM}	38	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	350	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
Power Dissipation	TO-220		156	W
	TO-220F/TO-220F1	P_{D}	50	W
	TO-220F2		48	W
Junction Temperature		TJ	+150	°C
Operating Temperature		T _{OPR}	-55 ~ +150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=7mH, I_{AS} =10A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 10A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
Junction to Case	TO-220	$\theta_{ extsf{JC}}$	0.8	°C/W
	TO-220F/TO-220F1		2.5	°C/W
	TO-220F2		2.6	°C/W

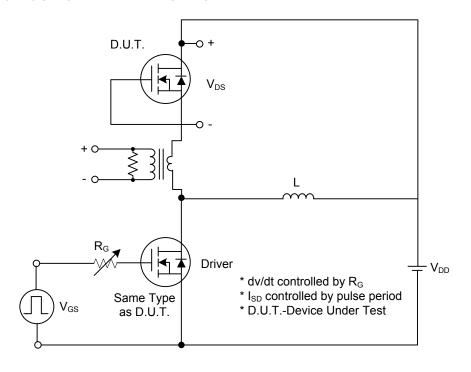
■ **ELECTRICAL CHARACTERISTICS**(T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_{D} = 250\mu A$	650			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} = 650V, V _{GS} = 0V			1	μA
Gate-Source Leakage Current	Forward	GSS	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
	Reverse		V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 5A$			1.0	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}			1500		pF
Output Capacitance		Coss	V_{DS} =25V, V_{GS} =0V, f=1.0 MHz		130		pF
Reverse Transfer Capacitance	Reverse Transfer Capacitance				25		pF
SWITCHING CHARACTERISTIC	S	C _{RSS}					
Turn-On Delay Time		$t_{D(ON)}$			60		ns
Turn-On Rise Time		t_R	V_{DD} =30V, I_{D} =0.5A,		120		ns
Turn-Off Delay Time		$t_{D(OFF)}$	R _G =25Ω (Note 1, 2)		310		ns
Turn-Off Fall Time		t_{F}			180		ns
Total Gate Charge		Q_{G}	V _{DS} =50V, I _D =1,3A,		39		nC
Gate-Source Charge		Q_GS	V _{GS} =50 V, I _D =1.3A, V _{GS} =10 V (Note 1, 2)		8.0		nC
Gate-Drain Charge			V _{GS} =10 V (Note 1, 2)		9.5		nC
DRAIN-SOURCE DIODE CHARA	CTERISTI	CS AND MA	XIMUM RATINGS	_			
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 10 \text{A}$			1.4	V
Maximum Continuous Drain-Source Diode		Is				10	Α
Forward Current						10	Α
Maximum Pulsed Drain-Source Diode		la				40	Α
Forward Current		I _{SM}				40	^
Reverse Recovery Time		t _{RR}	V _{GS} =0V, I _S =10A		420		ns
Reverse Recovery Charge		Q_{RR}	$dI_F/dt = 100 A/\mu s \text{ (Note 1)}$		4.2		μC

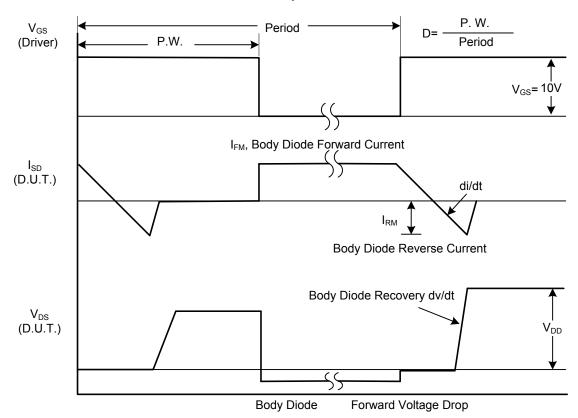
Note: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



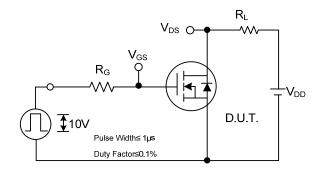
Peak Diode Recovery dv/dt Test Circuit

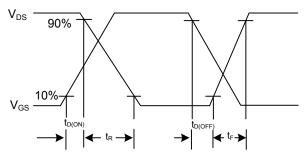


Peak Diode Recovery dv/dt Waveforms

10N65-Q

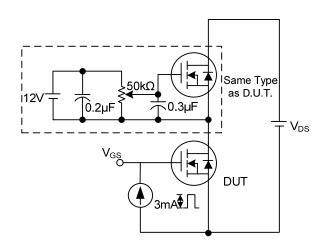
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

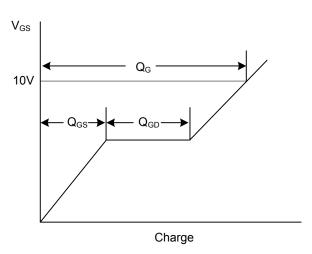




Switching Test Circuit

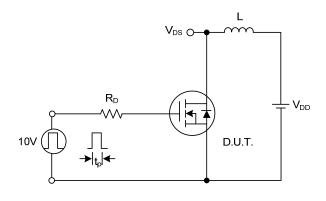
Switching Waveforms

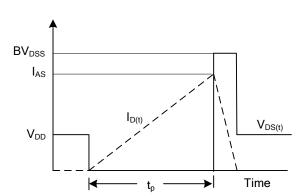




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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